

## IN THE UNITED STATES DESIGNATED/ELECTED OFFICE

International Application No.

PCT/EP00/05206

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6 JUNE 2000

Priority Date(s) Claimed

16 JUNE 1999

Applicant(s) (DO/EO/US)

EISENBEISS, Friedhelm, et al

Title: MINIATURIZED ANALYTICAL SYSTEM

## PRELIMINARY AMENDMENT

Commissioner for Patents Washington, D.C. 20231

SIR:

Prior to calculating the national fee, and prior to examination in the National Phase of the above-identified International application, please amend as follows:

## IN THE CLAIMS:

3. (Amended) Process for producing continuous-flow units for microstructured analytical systems according to Claim 1, characterized in that the alignment in step c) is performed using sputtered optical registration markers.

4. (Amended) Continuous-flow unit for a microstructured analytical system produced by a process corresponding to Claim 1.

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6. (Amended) Continous-flow unit for a microstructured analytical system corresponding to Claim
4, characterized in that the electrodes have an adhesive coating of chromium oxide and a
coating of noble metal.

**MERCK 2334**